



General Description

- Trench Power MOSFET - AlphaSGT™ technology
- Extremely Low $R_{DS(ON)}$
- Optimized switching performance
- 175°C operating temperature
- RoHS and Halogen-Free Compliant

Applications

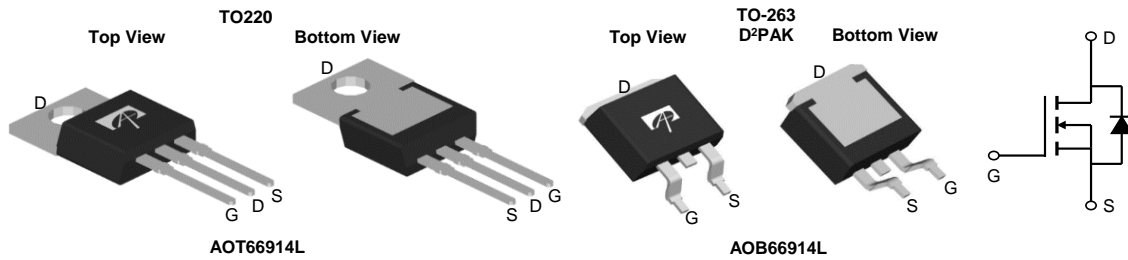
- Telecom DC-DC
- Industrial power
- Load switch
- Telecom Hot-Swap

Product Summary

| | |
|---------------------------------|---------|
| V_{DS} | 100V |
| I_D (at $V_{GS}=10V$) | 120A |
| $R_{DS(ON)}$ (at $V_{GS}=10V$) | < 2.7mΩ |
| $R_{DS(ON)}$ (at $V_{GS}=6V$) | < 3.5mΩ |

100% UIS Tested
100% Rg Tested

Max $T_j=175^\circ C$



| Orderable Part Number | Package Type | Form | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AOT66914L | TO-220 | Tube | 1000 |
| AOB66914L | TO-263 | Tape & Reel | 800 |

Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter | Symbol | Maximum | Units | |
|---|----------------|-------------------|------------|-----|
| Drain-Source Voltage | V_{DS} | 100 | V | |
| Gate-Source Voltage | V_{GS} | ± 20 | V | |
| Continuous Drain Current | I_D | 120 | A | |
| Current | | $T_C=100^\circ C$ | | 120 |
| Pulsed Drain Current ^c | I_{DM} | 480 | | |
| Continuous Drain Current | I_{DSM} | 45 | A | |
| Current | | $T_A=70^\circ C$ | | 38 |
| Avalanche Current ^c | I_{AS} | 90 | A | |
| Avalanche energy $L=0.1mH$ ^c | E_{AS} | 405 | mJ | |
| Power Dissipation ^b | P_D | $T_C=25^\circ C$ | 375 | W |
| | | $T_C=100^\circ C$ | 185 | |
| Power Dissipation ^a | P_{DSM} | $T_A=25^\circ C$ | 10 | W |
| | | $T_A=70^\circ C$ | 7 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 175 | $^\circ C$ | |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|--|-----------------|--------------|------|--------------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | 12 | 15 | $^\circ C/W$ |
| Maximum Junction-to-Ambient ^{A,D} | | Steady-State | 50 | |
| Maximum Junction-to-Case | $R_{\theta JC}$ | 0.26 | 0.40 | $^\circ C/W$ |

Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|--|---|-----|-------|--------|-------|
| STATIC PARAMETERS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | I _D =250μA, V _{GS} =0V | 100 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} =100V, V _{GS} =0V T _J =55°C | | | 1 5 | μA |
| I _{GSS} | Gate-Body leakage current | V _{DS} =0V, V _{GS} =±20V | | | ±100 | nA |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} , I _D =250μA | 2.5 | 3.0 | 3.5 | V |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V _{GS} =10V, I _D =20A T _J =125°C | | 2.2 | 2.7 | mΩ |
| | | V _{GS} =6V, I _D =20A | | 3.6 | 4.5 | mΩ |
| g _{FS} | Forward Transconductance | V _{DS} =5V, I _D =20A | | 68 | | S |
| V _{SD} | Diode Forward Voltage | I _S =1A, V _{GS} =0V | | 0.7 | 1 | V |
| I _S | Maximum Body-Diode Continuous Current ^G | | | | 120 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =50V, f=1MHz | | 12500 | | pF |
| C _{oss} | Output Capacitance | | | 3190 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 55 | | pF |
| R _g | Gate resistance | f=1MHz | 0.8 | 1.75 | 2.7 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q _{g(10V)} | Total Gate Charge | V _{GS} =10V, V _{DS} =50V, I _D =20A | | 155 | 220 | nC |
| Q _{gs} | Gate Source Charge | | | 48 | | nC |
| Q _{gd} | Gate Drain Charge | | | 31 | | nC |
| Q _{oss} | Output Charge | V _{GS} =0V, V _{DS} =50V | | 269 | | nC |
| t _{D(on)} | Turn-On DelayTime | V _{GS} =10V, V _{DS} =50V, R _L =2.5Ω, R _{GEN} =3Ω | | 36 | | ns |
| t _r | Turn-On Rise Time | | | 25 | | ns |
| t _{D(off)} | Turn-Off DelayTime | | | 90 | | ns |
| t _f | Turn-Off Fall Time | | | 40 | | ns |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =20A, di/dt=500A/μs | | 55 | | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =20A, di/dt=500A/μs | | 335 | | nC |

- A. The value of R_{θJA} is measured in a still air environment with T_A=25° C. The Power dissipation P_{DSM} is based on R_{θJA} ≤ 10s and the maximum allowed junction temperature of 175° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.
- B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- C. Single pulse width limited by junction temperature T_{J(MAX)}=175° C.
- D. The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.
- G. The maximum current rating is package limited.
- H. These tests are performed in a still air environment with T_A=25° C.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

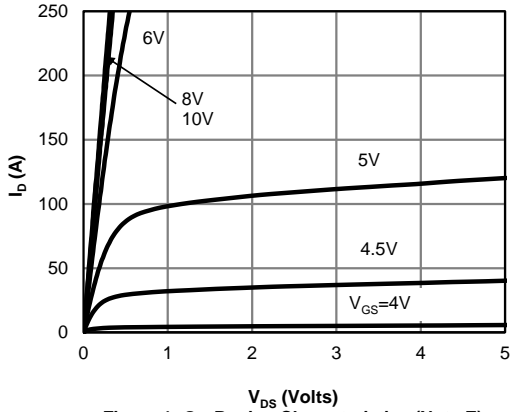


Figure 1: On-Region Characteristics (Note E)

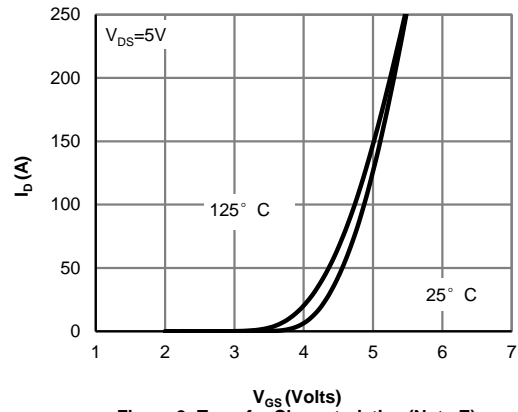


Figure 2: Transfer Characteristics (Note E)

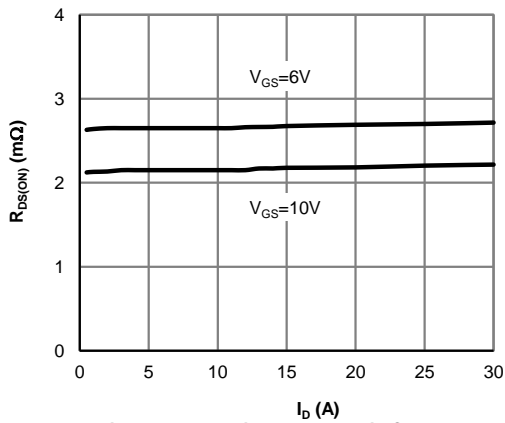


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

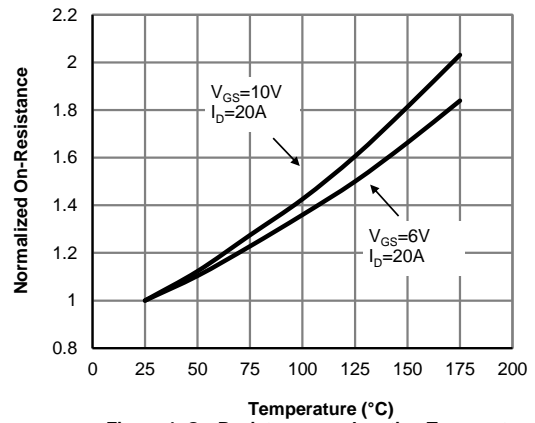


Figure 4: On-Resistance vs. Junction Temperature (Note E)

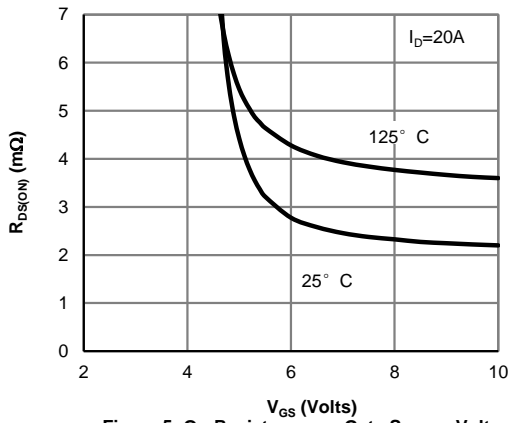


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

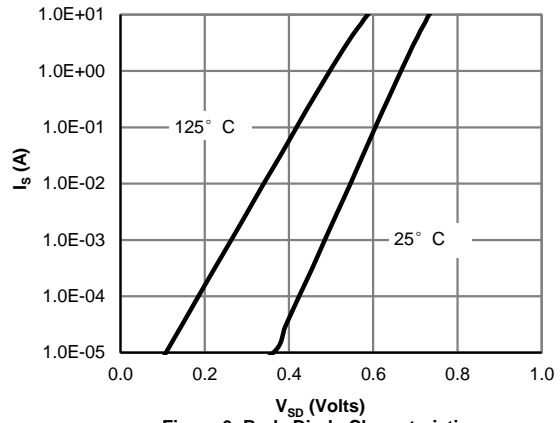


Figure 6: Body-Diode Characteristics (Note E)

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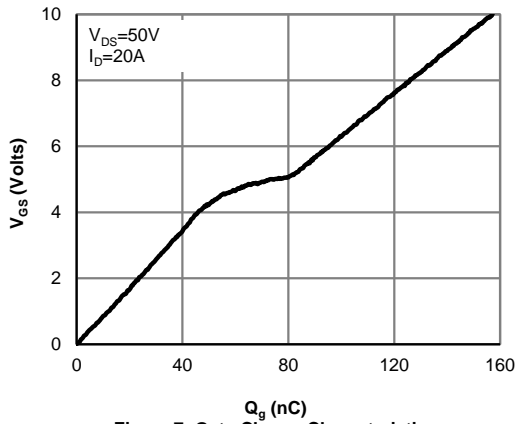


Figure 7: Gate-Charge Characteristics

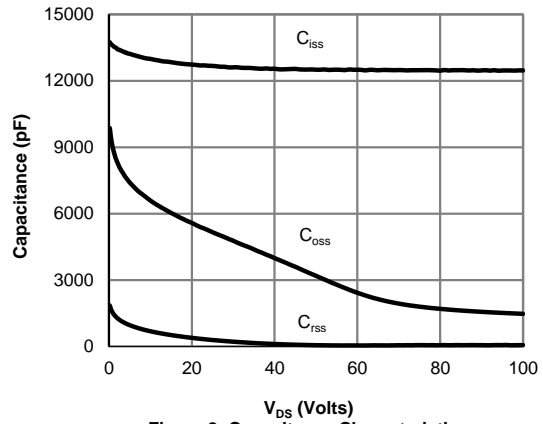


Figure 8: Capacitance Characteristics

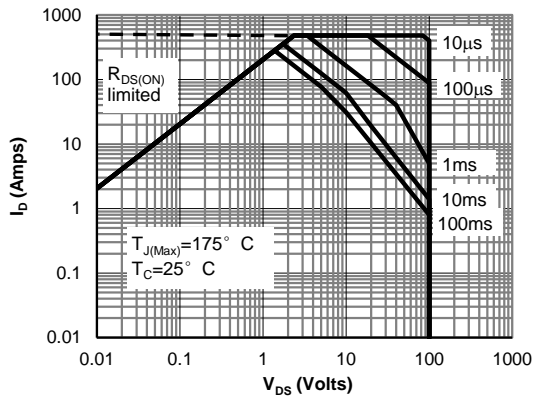


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

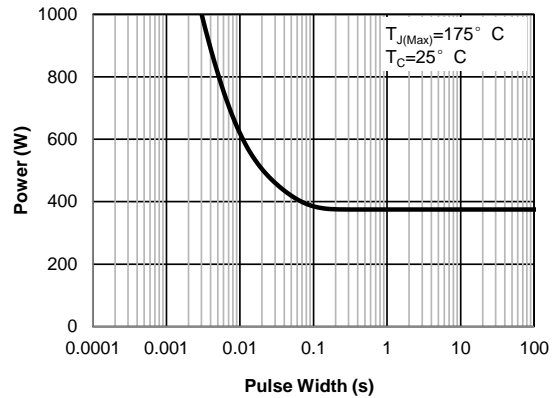


Figure 10: Single Pulse Power Rating Junction-to-Case (Note)

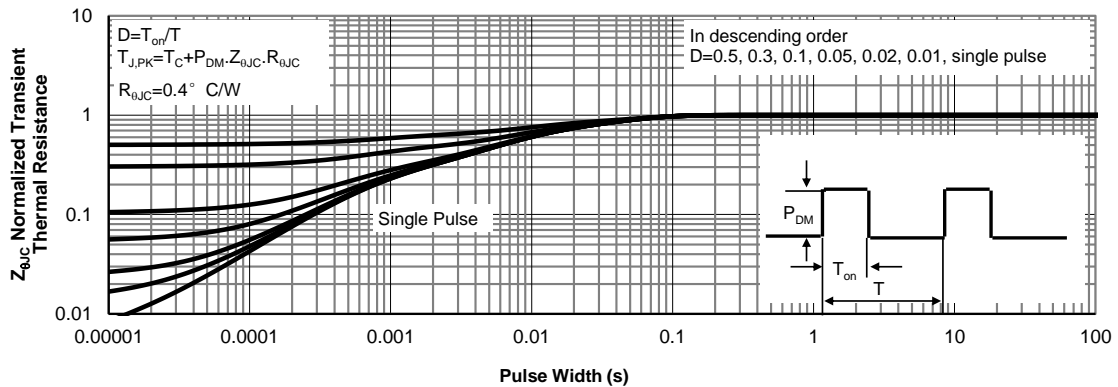


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

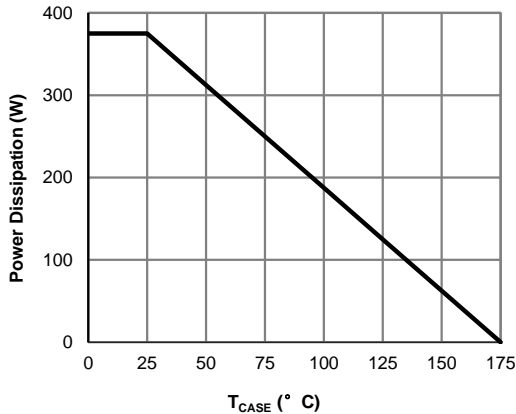


Figure 12: Power De-rating (Note F)

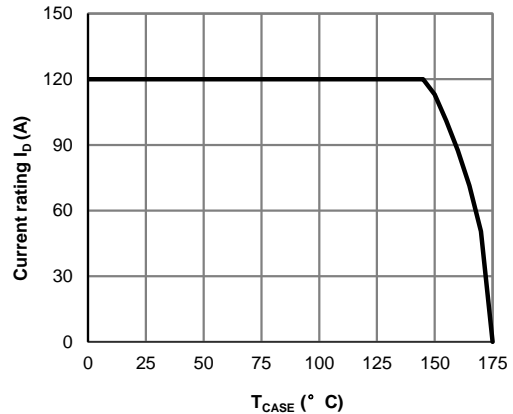


Figure 13: Current De-rating (Note F)

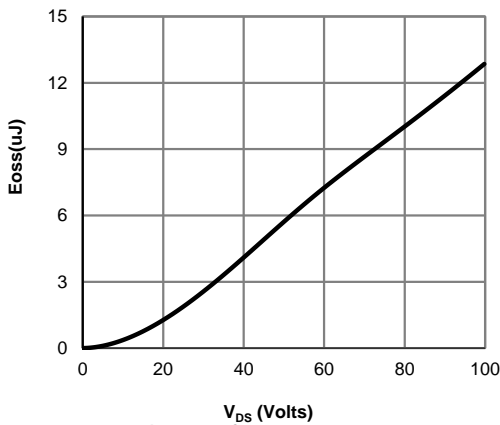


Figure 14: Coss stored Energy

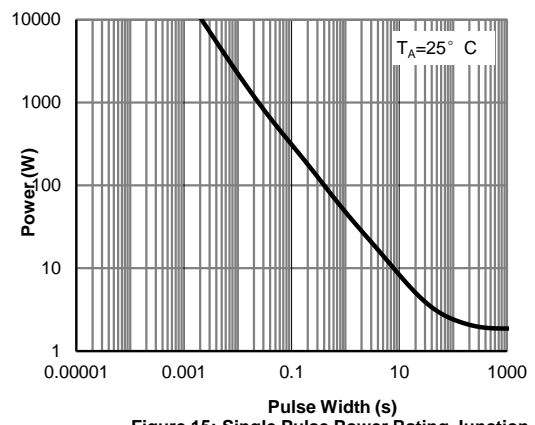


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

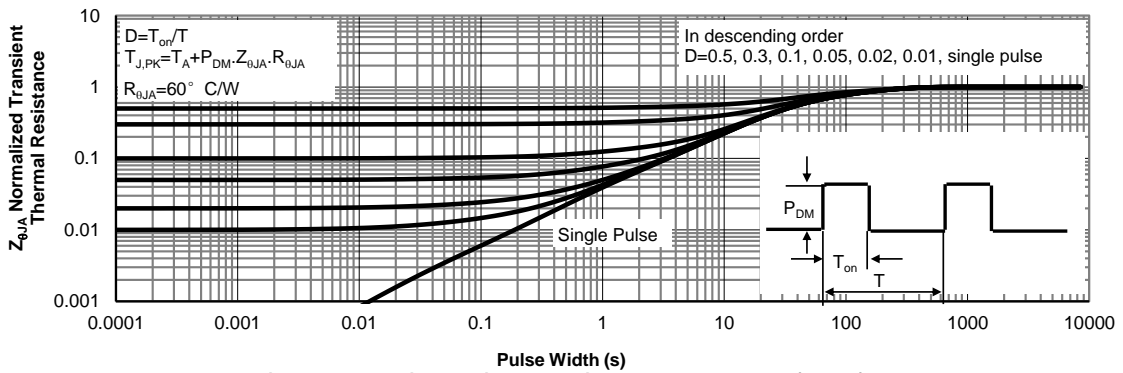


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

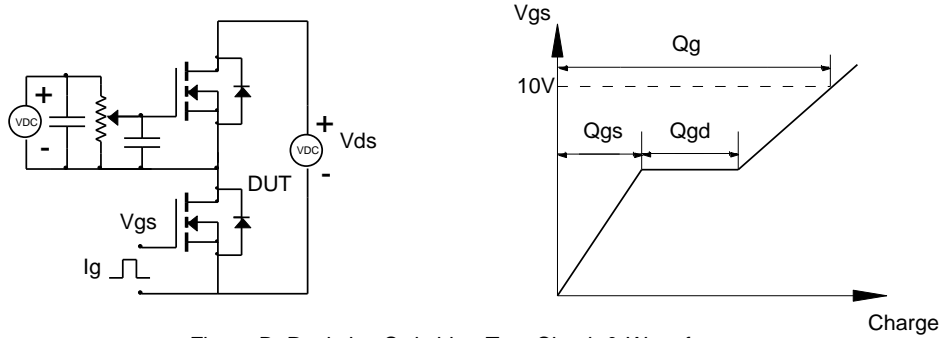


Figure B: Resistive Switching Test Circuit & Waveforms

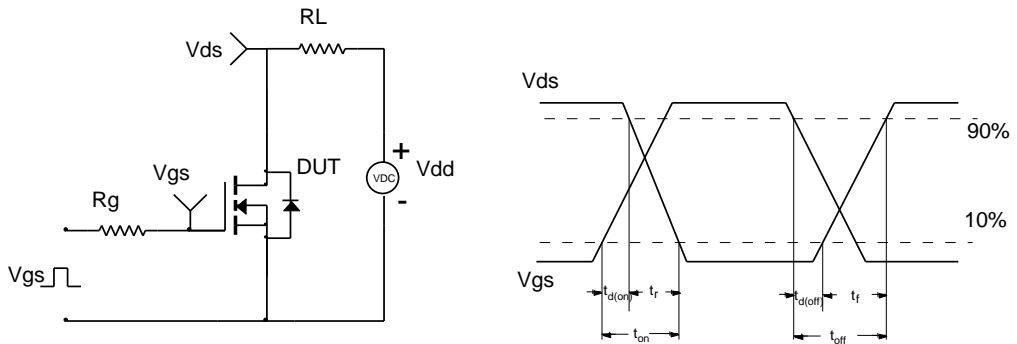


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

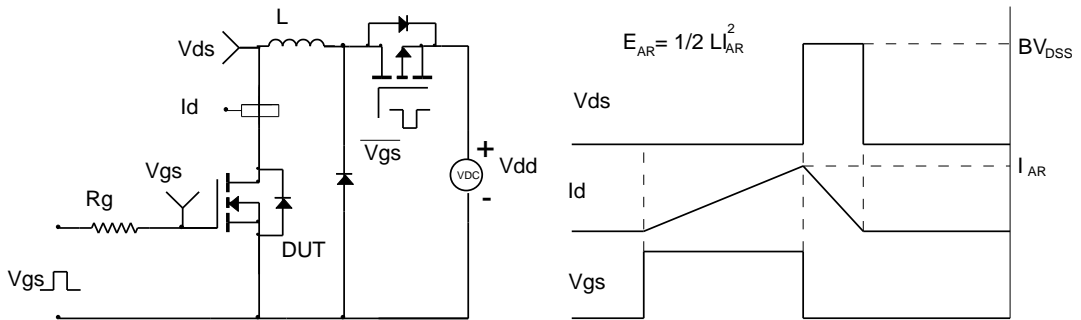


Figure D: Diode Recovery Test Circuit & Waveforms

